Top View

PROD

Vishay Siliconix

N-Channel 30 V (D-S) MOSFET

PowerPAK® 1212-8SH

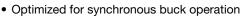
UCT SUMMARY					
	30				
nax. (Ω) at V _{GS} = 10 V	0.0089				

Bottom View

V_{DS} (V) R_{DS(on)} m 0.0124 $R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$ Q_g typ. (nC) 9.8 20 a, g $I_D(A)$ Configuration Single

FEATURES

TrenchFET® power MOSFET



• 100 % R_q and UIS tested

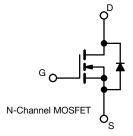
· Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

COMPLIANT

HALOGEN **FREE**

APPLICATIONS

- Notebook CPU core
 - High side switch



ORDERING INFORMATION	
Package	PowerPAK 1212-8
Lead (Pb)-free and halogen-free	SiSH472DN-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	30		
Gate-source voltage		V _{GS} ± 20		V	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		20 ^g		
	T _C = 70 °C	. –	20 ^g		
	T _A = 25 °C	I _D	15 ^{b, c}		
	T _A = 70 °C		12 ^{b, c}	^	
Pulsed drain current		I _{DM}	50	A	
Continuous source-drain diode current	T _C = 25 °C		20 ^g		
	T _A = 25 °C	I _S	3.2 b, c		
Single pulse avalanche current	J 0.1 mal J	I _{AS}	21		
Avalanche energy	L = 0.1 mH	E _{AS}	22	mJ	
Maximum power dissipation	T _C = 25 °C		28		
	T _C = 70 °C		18	10/	
	T _A = 25 °C	P _D	3.5 b, c	— w	
	T _A = 70 °C		2.2 ^{b, c}	\neg	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) d, e			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, f	t ≤ 10 s	R _{thJA}	29	36	°C/W	
Maximum junction-to-case (drain)	Steady state	R_{thJC}	3.6	4.5	C/VV	

Notes

- a. Base on T_C = 25 °C
- b. Surface mounted on 1" x 1" FR4 board
- See solder profile (www.vishav.com/doc?73257). The PowerPAK® 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components Maximum under steady state conditions is 81 °C/W
- Package limited

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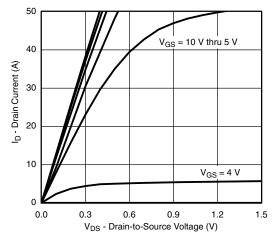
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static	· · · · · ·		<u>'I</u>				
Drain-source breakdown voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I 050 ·· A	-	28	-	\//90	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu\text{A}$	-	-5.5	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.2	-	2.5	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zero gate voltage drain current		V _{DS} = 30 V, V _{GS} = 0 V	-	-	1		
	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10	μA	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20	-	-	Α	
Drain-source on-state resistance ^a	Б	V _{GS} = 10 V, I _D = 15 A	-	0.0074	0.0089	Ω	
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 13 \text{ A}$	-	0.0103	0.0124		
Forward transconductance a	9 _{fs}	V _{DS} = 15 V, I _D = 13 A	-	49	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	997	-	pF	
Output capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	195	-		
Reverse transfer capacitance	C _{rss}		-	120	-		
	_	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 15 A	-	19.5	30	nC	
Total gate charge	Qg		-	9.8	15		
Gate-source charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$	-	3.7	-		
Gate-drain charge	Q _{gd}		-	3.7	-		
Gate resistance	R_{g}	f = 1 MHz	0.2	1.2	2.4	Ω	
Turn-on delay time	t _{d(on)}		-	19	29		
Rise time	t _r	$V_{DD} = 15 \text{ V}, R_L = 1.5 \Omega$	-	19	29		
Turn-off delay time	t _{d(off)}	$I_D\cong 10$ A, $V_{GEN}=4.5$ V, $R_g=1~\Omega$	-	19	29		
Fall time	t _f		-	13	20		
Turn-on delay time	t _{d(on)}		-	9	18	ns	
Rise time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω	-	9	18		
Turn-off delay time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	18	27		
Fall time	t _f		-	8	15		
Drain-Source Body Diode Characteris	tics					•	
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	20	_	
Pulse diode forward current ^a	I _{SM}		-	-	50	A	
Body diode voltage	V _{SD}	I _S = 10 A	-	0.85	1.2	V	
Body diode reverse recovery time	t _{rr}	-	-	14	28	ns	
Body diode reverse recovery charge	Q _{rr}	$I_{E} = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/µs},$	_	5	10	nC	
Reverse recovery fall time	ta	$T_J = 25 ^{\circ}\text{C}$	-	7	-		
Reverse recovery rise time	t _b		_	7	_	ns	

Notes

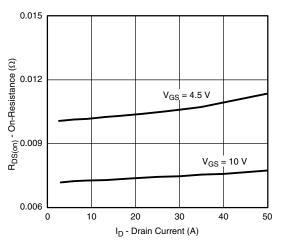
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

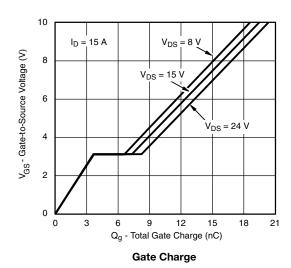


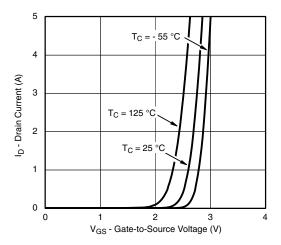


Output Characteristics

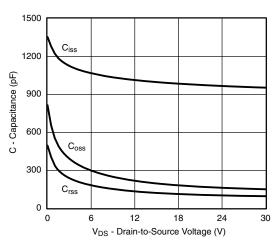


On-Resistance vs. Drain Current and Gate Voltage

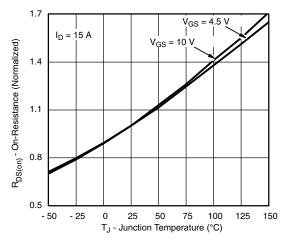




Transfer Characteristics

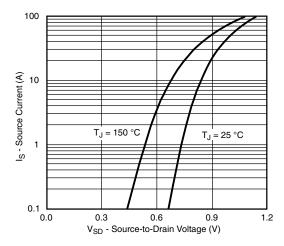


Capacitance

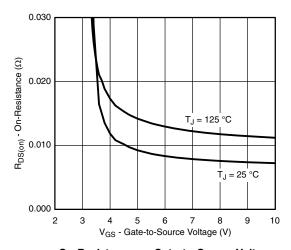


On-Resistance vs. Junction Temperature

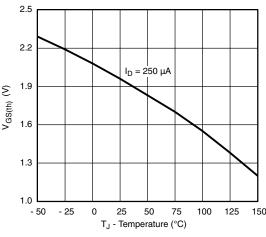




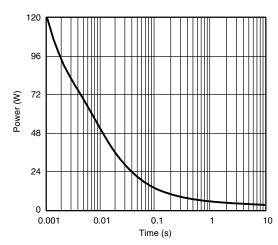
Source-Drain Diode Forward Voltage



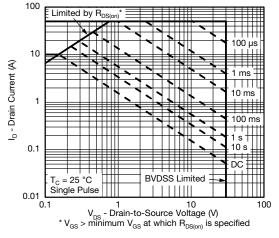
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

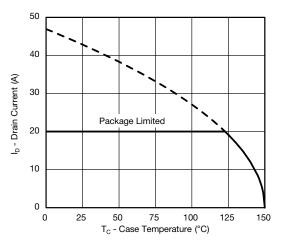


Single Pulse Power, Junction-to-Ambient

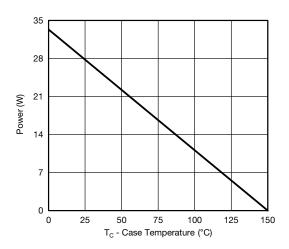


Safe Operating Area, Junction-to-Ambient

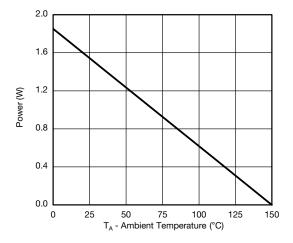




Current Derating a





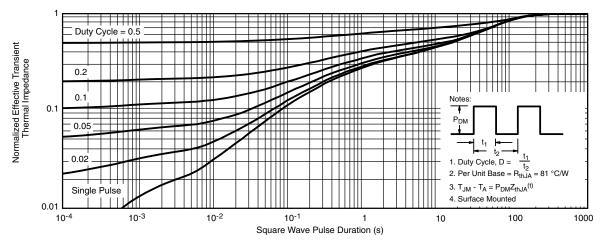


Power Derating, Junction-to-Ambient

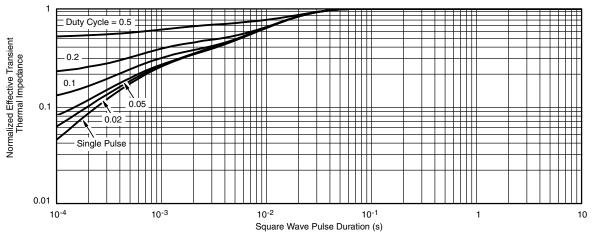
Note

a. The power dissipation P_D is based on T_J max = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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